

Notice of References Cited

Application/Control No.

09/990,862

Applicant(s)/Patent Under
Reexamination
HSIEH ET AL.

Examiner

Thao X Le

Art Unit

2814

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,383,873	05-2002	Hegde et al.	438/287
	B	US-2002/0047170	04-2002	Ota, Kazunobu	257/410
	C	US-2002/0151142	10-2002	Callegari et al.	438/287
	D	US-6,344,403	02-2002	Madhukar et al.	438/503
	E	US-6,013,553	01-2000	Wallace et al.	438/287
	F	US-2002/0115252	08-2002	Haukka et al.	438/240
	G	US-2001/0032995	10-2001	Maria et al.	257/310
	H	US-6,476,454	11-2002	Suguro, Kyoichi	257/410
	I	US-6,465,290	10-2002	Suguro et al.	438/183
	J	US-2001/0013616	08-2001	MERCHANT et al.	257/296
	K	US-2002/0089023	07-2002	Yu et al.	257/411
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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